

# N-Channel 30-V (D-S) MOSFET

V <sub>DS</sub>	30	V
R <sub>DS(on),typ</sub> V <sub>GS</sub> =10V	13	mΩ
RDS(on),typ VGS=4.5V	19	mΩ
ID	30	Α

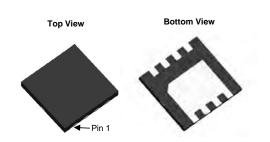
#### **FEATURES**

- · Halogen-free
- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested

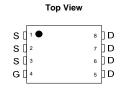


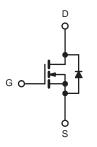
#### **APPLICATIONS**

- DC/DC Conversion
  - Low-Side Switch
- Notebook PC
- Gaming



DFN 3x3 EP





N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATIN</b>	IGS $T_A = 25 ^{\circ}C$	unless other	erwise noted	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		$V_{DS}$	30	V
Gate-Source Voltage		$V_{GS}$	± 20	V
	T <sub>C</sub> = 25 °C		30	
Continuous Drain Current (T <sub>.I</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	20	
Continuous Diam Current (1) = 130 C)	T <sub>A</sub> = 25 °C	טי [	21.5 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C	1 1	17.1 <sup>b, c</sup>	Α
Pulsed Drain Current		I <sub>DM</sub>	100	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	13	
	T <sub>A</sub> = 25 °C	's	3.1 <sup>b, c</sup>	
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	10	
Avalanche Energy	L = 0.111111	E <sub>AS</sub>	5	mJ
	$T_C = 25 ^{\circ}C$		60	
Maximum Power Dissipation	$T_C = 70  ^{\circ}C$	P <sub>D</sub>	30	w
	T <sub>A</sub> = 25 °C	] ' '	3.7 <sup>b, c</sup>	• • • • • • • • • • • • • • • • • • • •
	T <sub>A</sub> = 70 °C	<u>]                                    </u>	2.4 <sup>b, c</sup>	
Operating Junction and Storage Temperature	e Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	$R_{thJA}$	27	34	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	6	7.5	C/ V V	

#### Notes

- a. Based on  $T_C = 25$  °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under Steady State conditions is 85 °C/W.



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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				•			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	30			V	
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	J 250A		27		m\//00	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I <sub>D</sub> = 250 μA		- 5.6		mV/°0	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu\text{A}$	1.0		3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zara Oata Waltana Brain Oarrant	-	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V			1		
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	10 µA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
	<b>D</b>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A		13		mΩ	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 10 A		19			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A		75		S	
Dynamic <sup>b</sup>				ı			
Input Capacitance	C <sub>iss</sub>				900		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz			236	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	1			20		
Total Cata Chausa	$V_{DC} = 15 \text{ V}, V_{CC} = 10 \text{ V}, I_{D} = 10 \text{ A}$	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A			20	nC	
Total Gate Charge	$Q_g$				9		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$			2.1		
Gate-Drain Charge	$Q_gd$				0.7		
Gate Resistance	$R_g$	f = 1 MHz	0.2	1.1	2.2	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			8	16		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_{L}$ = 1.5 $\Omega$		16	30		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		17	35		
Fall Time	t <sub>f</sub>			7	15	nc	
Turn-On Delay Time	t <sub>d(on)</sub>			14	30	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		50	100		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		16	30		
Fall Time	t <sub>f</sub>			8	18		
<b>Drain-Source Body Diode Characteristi</b>	cs						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			13	۸	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				100	А	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 3 A			1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>				40	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 10 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C			20	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ al/at} = 100 \text{ A/µs}, I_J = 25 ^{\circ}\text{C}$		12.5			
Reverse Recovery Rise Time	t <sub>b</sub>	1		7.5		ns	

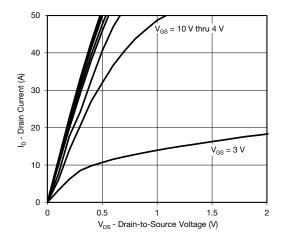
#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

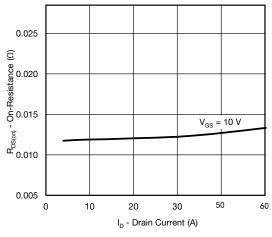
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%$ 

b. Guaranteed by design, not subject to production testing.

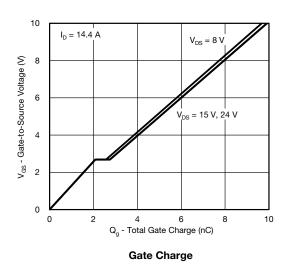


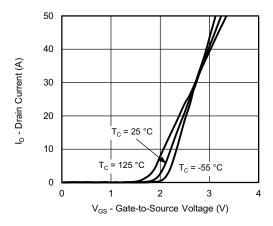


#### **Output Characteristics**

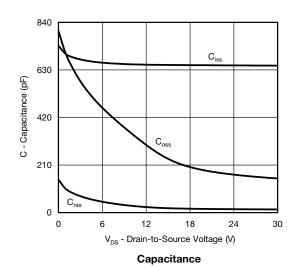


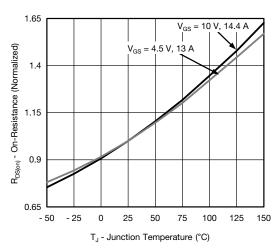
On-Resistance vs. Drain Current





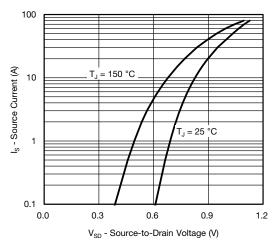
**Transfer Characteristics** 



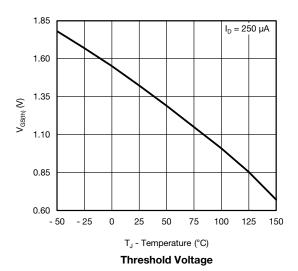


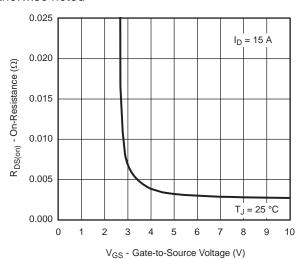
On-Resistance vs. Junction Temperature



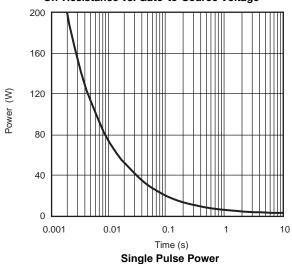


#### Source-Drain Diode Forward Voltage





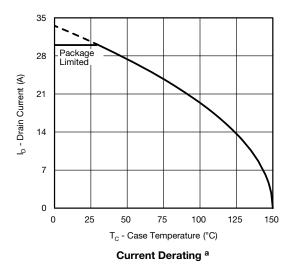
On-Resistance vs. Gate-to-Source Voltage

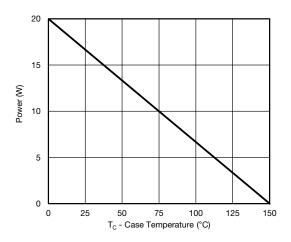


 $(3) \begin{array}{c} 100 \\ \text{Limited by } P_{\text{Oscion}} \\ \text{10} \\ \text{10}$ 

Safe Operating Area, Junction-to-Ambient





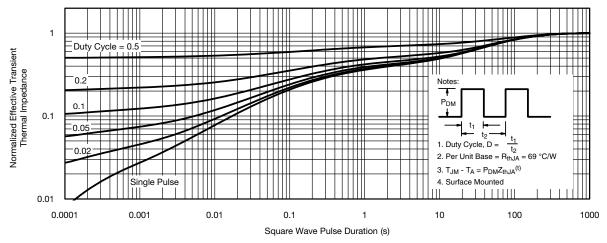


Power, Junction-to-Case

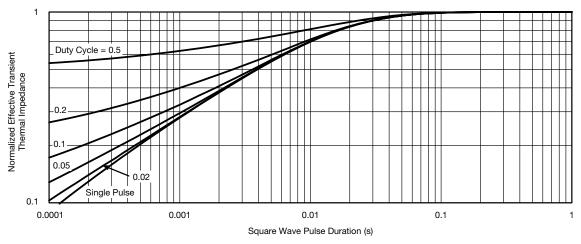
#### Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

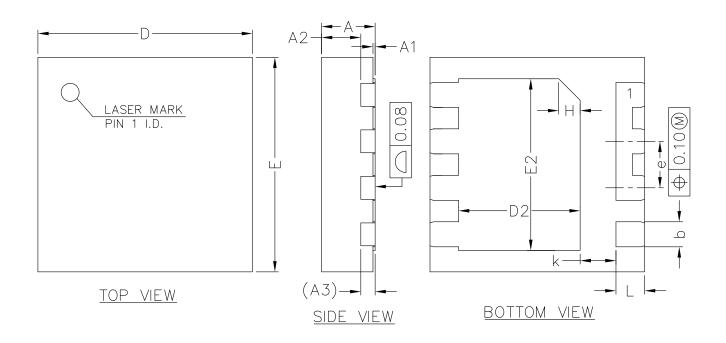


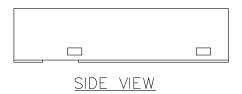
Normalized Thermal Transient Impedance, Junction-to-Case

服务热线:400-655-8788

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COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX	
Α	0.70	0.75	0.80	
A1	0.00	0.02	0.05	
A2	0.50	0.55	0.60	
A3	0.20REF			
b	0.30	0.35	0.40	
D	2.90	3.00	3.10	
Е	2.90	3.00	3.10	
D2	1.60	1.70	1.80	
E2	2.30	2.40	2.50	
е	0.55	0.65	0.75	
K	0.40	0.50	0.60	
L	0.35	0.40	0.45	



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DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 DMN2990UFB-7B
IPB80P04P405ATMA2 2N7002W-G MCAC30N06Y-TP MCQ7328-TP BXP7N65D BXP4N65F AOL1454G WMJ80N60C4 BXP2N20L
BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13 SLF10N65ABV2
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